Application/Control No. 09/668,291 Examiner EDMUND H LEE Applicant(s)/Patent Under Reexamination DEBALME ET AL. Art Unit Page 1 of 1

Notic of References Cited

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6294036	09-2001	Loubinoux et al	156/181
	В	US-5425981	06-1995	Bruning et al	428/198
	С	US-5037284	08-1991	Angell, Jr et al	425/112
*	D	US-3851456	12-1974	Hamada et al	57/140 BY
	E	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	j	US-			
	κ	US-			
	L	US-	-		
	М	US-			-

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	2	JP 11281860 A	10-1999	JP	Sanada et al	**********
	0					
	Ρ					
	σ					
	R					
	s					
	Т	,				

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	v	
	w	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

U.S. Patent and Trademark Office PTO-892 (Rev. 01-2001)